

<b>Notice of References Cited</b>	Application/Control No. 09/458,297	Applicant(s)/Patent Under Reexamination FIKES ET AL.	
	Examiner Ron Schwadron, Ph.D.	Art Unit 1644	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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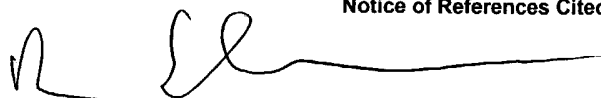
**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 96/22067	07-1996	WO	Kuebler et al.	---
	O					
	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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